

Model **AE-381A** Ultra high speed & high accuracy 1MHz/1kHz/120Hz MLCC Capacitor Checker

Optimum model for inspection on taping machine of MLCC Capacitor

Characteristic

- ■Ultra high speed (Measurement time): 0.3msec[1MHz], 1msec[1kHz], 8.34msec[120Hz],
- ■It is poor contact detection of the probe at the time of 2 terminal measurement by measurement abnormality detection.
- Available to make the contact check to watch the contact condition of probe contact.
- Measurement frequency: 1MHz/1kHz/120Hz±0.1%(a sine wave)
- ■BIN function: It is available to classified to 14 ranks maximum and out of BIN the C measurement values.
- Change possibility of series equivalent circuit/parallel equivalent circuit.
- Available to measure by constant voltage for the capacitor with the voltage dependence.

 (It is not supported some range)
- Available DF & Q measurement.
- ■4¹/₂figures(15000) display and available HI/GO/LO judgment by comparator
- "RS-232C" and "printer output" function (Centronics conformity) are as normal. ("GP-IB" is option)
- Supplies a measurement electric current by intermittent in order to reduce the abrasion of the probe contact.



AEMIC CORPORATION,



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SPECIFICATIONS

TENTATIVE

Measuring range and Accuracy (DF<0.1 Ambient temperature 23°C \pm 5°C)

Range	Measuring Range	Resolution	Accuracy[In case of FAST, Accuracy of C and DF becomes double]			Measuring Voltage[rms]
			1MHz	1kHz	120Hz	
1.5pF	0.0000pF∼1.5000pF	0.0001pF	C:Within±1.0% of rdg±50dg			1V±5%
		DF: 0. 0001	DF:Within±0.005±0.0001 × (Cr/Cx)			$0.5V \pm 5\%$
15pF	0. 000pF∼15. 000pF	0. 001pF	C:Within±0.25% of rdg±25dg	C:Within±0.25% of rdg±25dg		1V±5%
		DF: 0. 0001	DF:Within±0.002±0.0005×(Cr/Cx)	DF:Withi±0.002±0.00025×(Cr/Cx)		$0.5V \pm 5\%$
150pF	0. 00pF∼150. 00pF	0. 01pF	C:Within±0.15% of rdg±10dg	C:Within±0.15% of rdg±10dg		1V±5%
		DF: 0. 0001	DF:Within±0.001±0.0001 × (Cr/Cx)	DF:Within±0.001±0.0001 × (Cr/Cx)		$0.5V \pm 5\%$
1. 5nF	0. 0pF~1500. 0pF	0. 1pF	C:Within±0.15% of rdg±10dg	C:Within±0.15% of rdg±10dg		1V±5%
		DF: 0.0001	DF:Within±0.001±0.0001 × (Cr/Cx)	DF:Withi±0.0005±0.0001 × (Cr/Cx)		$0.5V \pm 5\%$
15nF	0. 000nF~15. 000nF	0. 001nF		C:Within±0.15% of rdg±10dg		1V±5%
		DF: 0.0001		DF:Withi±0.0005±0.0001 × (Cr/Cx)		$0.5V \pm 5\%$
150nF	0. 00nF~150. 00nF	0. 01nF		C:Within±0.15% of rdg±10dg		1V±5%
		DF: 0.0001		DF:Withi±0.0005±0.0001 × (Cr/Cx)		$0.5V \pm 5\%$
1. 5µF	0. 0nF~1500. 0nF	0. 1nF		C:Within±0.15% of rdg±10dg	C:Within±0.15% of rdg±10dg	1V±5%
		DF: 0.0001		DF:Withi±0.0005±0.0001 × (Cr/Cx)	DF:Withi±0.0005±0.0001 × (Cr/Cx)	$0.5V \pm 5\%$
15µF	0. 000μF~15. 000μF	0. 001µF		C:Within±0.3% of rdg±20dg	C:Within±0.15% of rdg±10dg	1V±5%
		DF: 0.0001		DF:Within±0.001±0.0002×(Cr/Cx)	DF:Within±0.001±0.0002×(Cr/Cx)	$0.5V \pm 5\%$
150µF	0. 00μF~150. 00μF	0. 01µF		C:Within±1% of rdg±50dg	C:Within±0.5% of rdg±25dg	1kHz : 1V/0.5V +5%~-20%
		DF: 0. 0001		DF:Within±0.005±0.0005×(Cr/Cx)	DF:Within±0.003±0.0005×(Cr/Cx)	120Hz : 0.5V±5%
1.5mF	0. 0μF~1500. 0μF	0. 1µF			C:Within±1.5% of rdg±50dg	120Hz/0.5V+5%~−25%
		DF:0.0001			DF:Within±0.01±0.001 × (Cr/Cx)	

XIn case of Measuring Voltage is 0.5Vrms, Accuracy of C and DF becomes double.

Measurement Method	3 or 5 terminal measurement [Available to select the measuring method on each range]		
Measuring Frequency	1MHz/1kHz/120Hz±0.1%, sine wave		
Output Impedance	Approx. 2Ω		
Straycapacity revision range	Approx. 20pF		
temperature coefficient	Within ±100ppm/°C[f.s and zero]		
Measurement time	[Free running]FAST: Aprrox.1∼5 time/sec. SLOW: FAST × N(N: The setting number of "average")		
	[Start trigger signal]FAST: 0.3msec.[1MHz], 1msec.[1kHz], 8.34msec.[120Hz]		
Measuring range	Capacitance: 0~15000 DF: 0.0000~0.5000 Q:0~10000		
BIN function	C:14 ranks & out of bin		
Use environment	Temperature:0°C∼+50°C、 Humidity:Less than 85%		
Power supply	AC85V~265V、50~60Hz、Aprrox. 50VA		
Outer dimension	250(W) × 99(H) × 300(D)mm		
Weight	Approx. 3.5kg		

Option	GP-IB	

* We will change the specifications of the catalogue without notice by improvement.

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